

<b>Notice of References Cited</b>	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10/042,913	FAN ET AL.
	Examiner	Art Unit
	Julian Mercado	1745
		Page 1 of 1

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	B	US-5,464,706	11-1995	Dasgupta et al.	429/218.1
	C	US-6,022,641	02-2000	Endo et al.	429/232
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	K	US-			
	L	US-			
	M	US-			

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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)		
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